Search Notes



Application/Control No.

Applicant(s)/Patent under Reexamination

10/563,342 Examiner

/Yonel Beaulieu/

TOOYAMA, TADASHI

3661

	SEARCHED					
Class	Subclass	Date	Examiner			
701	29	7/16/2008	YB			
	36					
	49					
307	9.1					
	10.8					
362	459-460					
	464-465					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
Int. Search		7/17/2008	YB	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST+Int.+Fwd/Bwd	7/17/2008	YB		